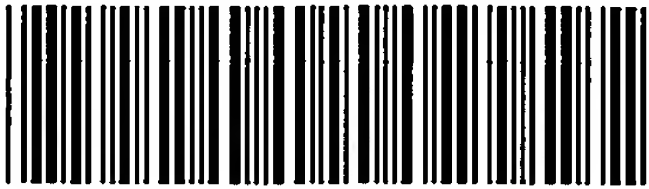


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/665,280	TAKEDA ET AL.	
	Examiner	Art Unit	
	Thoi V. Duong	2871	

SEARCHED			
Class	Subclass	Date	Examiner
349	123, 128, 129	12/9/2005	TVD

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	12/9/2005	TVD